

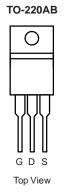
STP9NK90Z-VB Datasheet

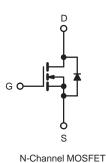
N-Channel 900V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	900				
R _{DS(on)} (Ω)	V _{GS} = 10 V 0.95				
Q _g (Max.) (nC)	200				
Q _{gs} (nC)	24				
Q _{gd} (nC)	110				
Configuration	Single				

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC





PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V _{DS}	900	- V	
Gate-Source Voltage	V _{GS}	± 20		
Continuous Drain Current	V_{GS} at 10 V $T_C = 25 \degree C$	I _D	7.0	
Continuous Drain Current	$T_{\rm C} = 100 ^{\circ}{\rm C}$		5.5	А
Pulsed Drain Current ^a	I _{DM}	21	1	
Linear Derating Factor		1.5	W/°C	
Single Pulse Avalanche Energy ^b	E _{AS}	770	mJ	
Repetitive Avalanche Current ^a	I _{AR}	7.8	A	
Repetitive Avalanche Energy ^a	E _{AR}	19	mJ	
Maximum Power Dissipation	n Power Dissipation T _C = 25 °C		190	W
Peak Diode Recovery dV/dt ^c	dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d	
Mounting Torque	6-32 or M3 screw		10	lbf · in
Mounting Torque	0-32 OF IVIS SCREW		1.1	N · m

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. V_{DD} = 50 V, starting T_J = 25 °C, L = 23 mH, R_g = 25 Ω , I_{AS} = 7.8 A (see fig. 12). c. I_{SD} \leq 7.8 A, dl/dt \leq 140 A/µs, V_{DD} \leq 600 V, T_J \leq 150 °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

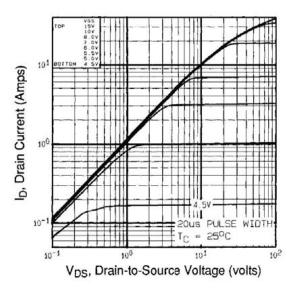
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THERMAL RESISTANCE RATI	NGS							
PARAMETER	SYMBOL	TYP.		MAX.			UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-		40				
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24		-			°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-		0.65				
SPECIFICATIONS (T _J = 25 °C, u PARAMETER	SYMBOL	1			MIN.	TYP.	MAX.	UNIT
Static	STMDUL	IES	T CONDIT		IVIIN.	TTP.		UNIT
Drain-Source Breakdown Voltage	V _{DS}	Vaa	= 0 V, I _D =	250 µA	900	-	-	V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J			$I_D = 1 \text{ mA}$	300	0.98	_	V/°C
Gate-Source Threshold Voltage		+			2.0	-		V/ C
3	V _{GS(th)}		$= V_{GS}, I_D =$ $V_{GS} = \pm 20$		- 2.0		4.0	-
Gate-Source Leakage	I _{GSS}				-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		= 900 V, V ₀		-	-	100	μA
Drain-Source On-State Resistance	D ₋	$v_{DS} = 720 V_{CS} = 10 V$		$V, T_{\rm J} = 125 ^{\circ}{\rm C}$ $_{\rm D} = 5.6 ^{\rm Ab}$	-	-	500 -	Ω
Forward Transconductance	R _{DS(on)}		ינ : 100 V, I _D		5.6	0.95	-	S S
Dynamic	g fs	VDS -	· 100 v, ib	- 3.0 A	5.0			3
Input Capacitance	C _{iss}				_	3100	-	1
Output Capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = 25 V,		-	800	-	pF	
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, se		_	490	_	pr
Total Gate Charge	Qg				-		200	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		A, V _{DS} = 400 V,	-	_	24	nC
Gate-Drain Charge	Q _{gd}	VGS = 10 V	see fig. 6 and 13 ^b		-	_	110	
Turn-On Delay Time	t _{d(on)}				_	19	-	
Rise Time	t _r	- Voo =	= 400 V In	= 5 6 A	_	38	_	
Turn-Off Delay Time	t _{d(off)}		= 6.2 Ω, R _D	= 52 Ω	_	120	_	ns
Fall Time	t _f	$R_{g}^{P} = 6.2 \Omega, R_{D}^{P} = 52 \Omega^{2}$ see fig. 10 ^b			-	-		
Internal Drain Inductance	L _D	ů – –		-				
Internal Source Inductance	L _S			13	-	nH		
Drain-Source Body Diode Characteristic	S					1	1	1
Continuous Source-Drain Diode Current	I _S	MOSFET sym showing the	bol		-	-	5.0	
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	21	- A		
Body Diode Voltage	V _{SD}	T_J = 25 °C, I_S = 5.6 A, V_{GS} = 0 V ^b		-	-	1.8	V	
Body Diode Reverse Recovery Time	t _{rr}			-	650	980	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	3.8	5.7	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time	is negligible (turn	-on is do	minated h	$v L_s and$	Ln)

Notes

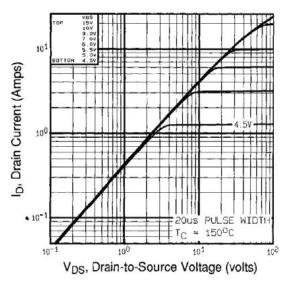
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)







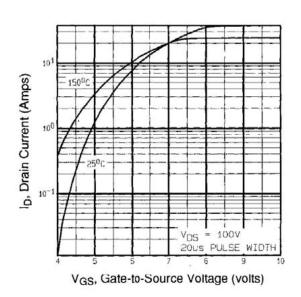
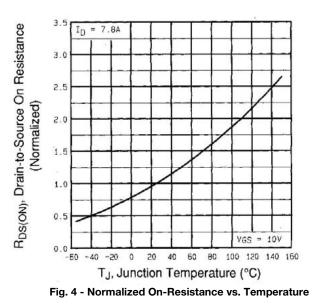


Fig. 3 - Typical Transfer Characteristics





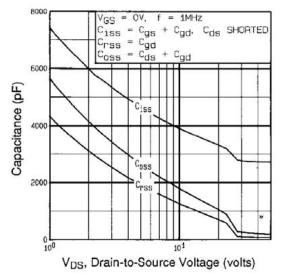
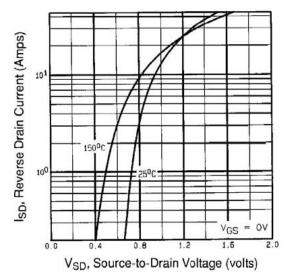


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





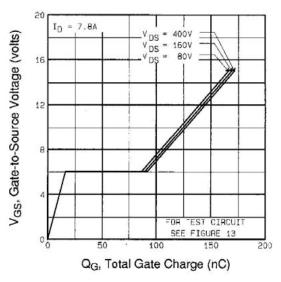
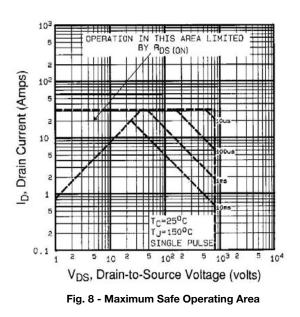


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





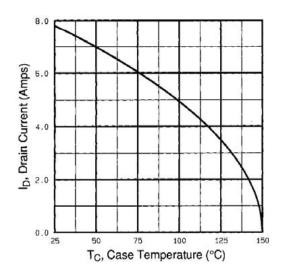


Fig. 9 - Maximum Drain Current vs. Case Temperature

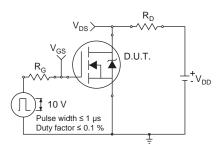


Fig. 10a - Switching Time Test Circuit

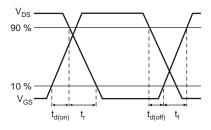


Fig. 10b - Switching Time Waveforms

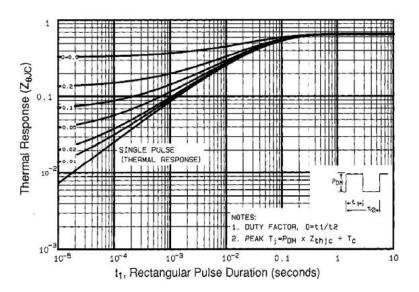


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



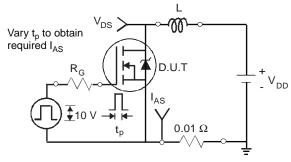


Fig. 12a - Unclamped Inductive Test Circuit

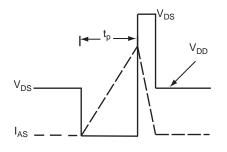


Fig. 12b - Unclamped Inductive Waveforms

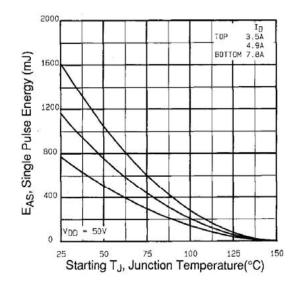


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

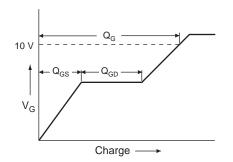


Fig. 13a - Basic Gate Charge Waveform

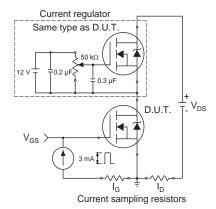
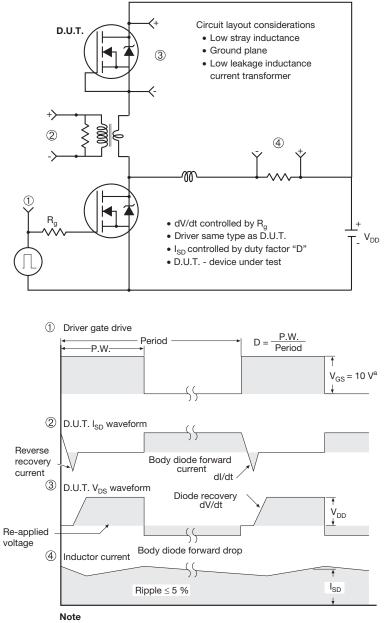


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

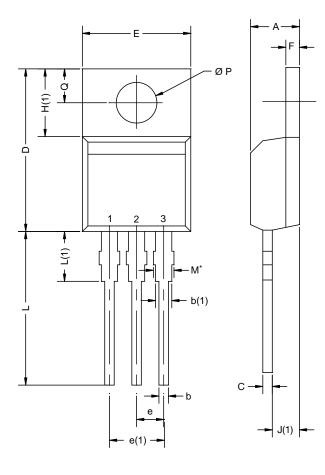


a. $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



TO-220AB



	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12			

Notes

 * M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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